

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Hiroyuki FUKITA et al.

Serial No.: New Application

Group Art Unit:

Filed: March 21, 2002

Examiner:

For: METHOD FOR FINE PATTERN FORMATION

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
Washington, D.C. 20231

Sir:

Pursuant to 37 C.F.R. §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached Form PTO-1449. Copies of each of the references listed on Form PTO-1449 are attached.

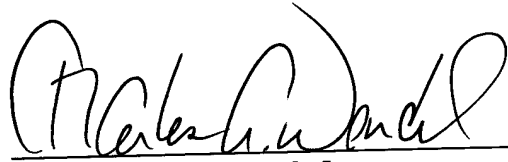
Also enclosed is a copy of a International Search Report bearing a mailing date of January 15, 2002, and the U.S. PTO is directed thereto for a concise statement of possible relevance of the references cited therein.

The above information is presented so that the Patent and Trademark Office may, in the first instance, determine any materiality thereof to the claimed invention. See 37 C.F.R. 1.104(a) and 1.106(b) concerning the PTO duty to consider and use

any such information. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that these references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

Respectfully submitted,

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March 21, 2002
Date

CAW/ch

Attorney Docket No.: DAIN:673

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(rev. 4/96)

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)ATTY DOCKET NO.
DAIN:673SERIAL NO.
New ApplicationAPPLICANT
Hiroyuki FUKITA et al.FILING DATE
March 21, 2002

GROUP

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO YES
✓	2000-167463	6/20/00	Japan (w/Abstract)			X
✓	9-57981	3/4/97	Japan (w/Abstract)			X
✓	8-071477	3/19/96	Japan (w/Abstract)			X
✓	11-239748	9/7/99	Japan (w/Abstract)			X
✓	2000-189873	7/11/00	Japan (w/Abstract)			X
✓	EP 0 985 534 A1	3/15/00	EPO			

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applica-